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PATENT NUMBER and
ISSUE DATE

U.S. UTILITY Patent Application

APPL NUM	FILING DATE	CLASS	SUBCLASS	GAU	EXAMINER
10003224	10/26/2001	378	306	2881 2882	Johnson

**APPLICANTS: Larson Paul; Moulder John; Watson David; Perloff David;

2881

**CONTINUING DATA VERIFIED:

THIS APPLICATION IS A CIP OF 10/075,571 10/26/2001

2880/306 Johnson

** FOREIGN APPLICATIONS VERIFIED:

PG-PUB	DO NOT PUBLISH <input type="checkbox"/>	RESCIND <input type="checkbox"/>	
Foreign priority claimed 35 USC 119 conditions met		<input type="checkbox"/> yes <input checked="" type="checkbox"/> no <input type="checkbox"/> yes <input checked="" type="checkbox"/> no	ATTORNEY DOCKET NO
Verified and Acknowledged Examiner's initials		278.00060120	
TITLE : System and method for characterization of thin films			
U.S. DEPT. OF COMM./PAT. & TM-PTO-438L (Rev. 12-94)			

NOTICE OF ALLOWANCE MAILED

ISSUE FEE

Amount Due	Date Paid
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TERMINAL

DISCLAIMER

Assistant Examiner

CLAIMS ALLOWED

Total Claims	Print Claim for O.G
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DRAWING

Sheets Drwg.	Figs. Drwg.	Print Fig.
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Primary Examiner

Application Examiner

PREPARED FOR ISSUE

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